

DATE: 23<sup>rd</sup> February, 2016

PCN #: 2181 REV 01

PCN Title: Conversion to Copper Bond Wire, Additional A/T site, and/or Additional Wafer Source with Smaller Die Size on Selected Discrete Products

Dear Customer:

This is an announcement of change(s) to products that are currently being offered by Diodes Incorporated.

We request that you acknowledge receipt of this notification within 30 days of the date of this PCN. If you require samples for evaluation purposes, please make a request within 30 days as well. Otherwise, samples may not be built prior to this change. Please refer to the implementation date of this change as it is stated in the attached PCN form. Please contact your local Diodes sales representative to acknowledge receipt of this PCN and for any sample requests.

The changes announced in this PCN will not be implemented earlier than 90 days from the notification date stated in the attached PCN form.

Previously agreed upon customer specific change process requirements or device specific requirements will be addressed separately.

For questions or clarification regarding this PCN, please contact your local Diodes sales representative.

Sincerely,

Diodes Incorporated PCN Team



## PRODUCT CHANGE NOTICE

## PCN-2181 REV 01

23 <sup>rd</sup> February, 2016 Conversion to Copper	22 <sup>nd</sup> May, 2016 Bond Wire, Additional <i>i</i>	Discrete Semiconductors TITLE	Bond Wire Material / Wafer FAB Material / Additional Assembly & Test Site	2181
	Bond Wire, Additional	TITI F	,	
	Bond Wire, Additional		· · · · · ·	
		A/T site, and/or Additiona Discrete Products	al Wafer Source with Smaller Die Size	on Selected
		DESCRIPTION OF CHA	NGE	
Diodes internal FabTech Company Limited" (CAT) Full electrical characteriz Copper bond wire, alter electrical specifications in There will be no change a REV 01: Add part number	n Inc. (KFAB) or externa ) as an additional Asser zation and high reliabil rnative wafer source a n the datasheet. to the Form, Fit, or Fun ers: MMBT2222A-13-F	I Phenitec Semiconductombly & Test Site (A/T Site) ity testing has been cor and/or additional A/T site action of affected product	additional wafer source with smaller d or (*), and qualified "Diodes Technolog e) for the selected Discrete products. Inpleted on representative part number te to ensure no change to device fu s. ST2222A-7-F – Change: Additional Wa	y (Chengdu) ers built using unctionality or
with Smaller Die Size (Ta	adle 4)	IMPACT		
There is no change in da	atasheet parameters an	d product performance.		
		PRODUCTS AFFECT	ED	
Please refer to Table 1 fo Please refer to Table 2 fo Please refer to Table 3 fo Please refer to Table 4 fo	or Cu bond wire conver or additional A/T site ar	sion and additional wafe	r source with smaller die size e with smaller die size	
Manufacturer's Notice:	http://www		3	
For More Information C				
Data Sheet:	http://www.diodes.com/products			
		DISCLAIMER		



Table 1 - Cu Bond Wire Conversion				
DCX114EU-7-F	DDC114TU-7-F	DDTA144WE-7-F	DCX114EH-7	ZUMT718TA
DCX114TU-7-F	DDC114YU-7-F	DDTC113ZE-7-F	DDA114EH-7	ZUMT720TA
DCX114YU-7-F	DDC123JU-7-F	DDTC114EE-7-F	DDA114TH-7	BC817-40W-7
DCX123JU-7-F	DDC124EU-7-F	DDTC114GE-7-F	DDA114YH-7	MMST5401-7-F
DCX124EU-7-F	DDC143TU-7-F	DDTC114YE-7-F	DDA124EH-7	MMST5551-7-F
DCX143EU-7-F	DDC144EU-7-F	DDTC115EE-7-F	DDC114EH-7	MMST6427-7-F
DCX143TU-7-F	DDC144NS-7	DDTC122LE-7-F	DDC114YH-7	MMSTA13-7-F
DCX144EU-7-F	DDC144TU-7	DDTC123JE-7-F	DDC123JH-7	MMSTA14-7-F
DDA113TU-7-F	DDTA113TE-7-F	DDTC123YE-7-F	DDC142TH-7	MMSTA42-7-F
DDA114EU-7-F	DDTA113ZE-7-F	DDTC124EE-7-F	DDC143TH-7	MMSTA55-7-F
DDA114TU-7-F	DDTA114EE-7-F	DDTC124XE-7-F	ZUMT491TA	MMSTA56-7-F
DDA114YU-7-F	DDTA114WE-7-F	DDTC143EE-7-F	ZUMT591TA	MMSTA92-7-F
DDA123JU-7-F	DDTA123JE-7-F	DDTC143TE-7-F	ZUMT617TA	2DB1689-7
DDA143TU-7-F	DDTA123YE-7-F	DDTC143XE-7-F	ZUMT618TA	2DB1694-7
DDA144EU-7-F	DDTA143EE-7-F	DDTC143ZE-7-F	ZUMT619TA	2DD2652-7
DDC113TU-7-F	DDTA143TE-7-F	DDTC144EE-7-F	ZUMT619TC	2DD2656-7
DDC114EU-7-F	DDTA144EE-7-F	DDTC144WE-7-F	ZUMT717TA	T6V0S5-7

Table 2 - Cu Bond Wire Conversion and Additional Wafer Source with Smaller Dies Size				
MMBT2907AT-7-F	MMDT2222V-7	MMDT2907V-7	MMDT3906VC-7	MMBT3906T-13-F
MMBT2222A-7-G	DLP05LC-7-F*			

\* Phenitec Semiconductor as an additional wafer source

Table 3 - Additional A/T site and Additional Wafer Source with Smaller Die Size				
MMDT4124-7-F	MMDT3946-7-F	MMBT4126-7-F	MMBT3904-13-F	DMMT3904W-7-F
MMDT3906-7-F	MMDT4146-7-F	MMDT3904-7-F	MMBT3906-13-F	DMMT3906W-7-F
MMDT4126-7-F	MMBT4124-7-F	MMDT2907A-7-F		

Table 4 - Additional Wafer Source with Smaller Die Size					
MMBT2222AT-7-F	MMDT3904VC-7	MMST3904-7-F	MMST4126-7-F	MMBT2907A-13-F	
MMBT3904T-7-F	MMDT2222A-7-F	MMST3906-7-F	MMBT3904-7-F	MMBT2907A-7-F	
MMBT3906T-7-F	MMDT2227-7-F	MMST4124-7-F	MMBT3906-7-F	MMDT2227M-7	
MMDT3904V-7	MMST2907A-7-F				